


<b>Search Notes</b> 	<b>Application/Control No.</b> 10661612	<b>Applicant(s)/Patent Under Reexamination</b> COYNE ET AL.
	<b>Examiner</b> Pardo, Thuy N	<b>Art Unit</b> 2627

SEARCHED			
Class	Subclass	Date	Examiner
707	10, 101, 104.1	5/31/2007	TP
709	202, 237	5/31/2007	TP
707	102, 103R	12/21/2007	TP
707	4	8/15/2008	TP
709	224	8/15/2008	TP
709	227	5/9/2009	TP
717	113	5/9/2009	TP
707	10, 104.1, 101, 102, 103X, 210, 203	12/5/2009	TP
709	225	12/5/2009	TP
710	008	12/5/2009	TP
715	507	12/5/2009	TP
713	170	12/5/2009	TP
711	170	12/5/2009	TP
705	1	12/5/2009	TP

SEARCH NOTES			
Search Notes		Date	Examiner
WEST		5/31/2007	TP
WEST		12/21/2007	TP
WEST, ACM, Google		8/15/2008	TP
WEST, Google Scholar		5/9/2009	TP
WEST, NPL: ACM		12/5/2009	TP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
707	4, 10, 104.1, 101, 102, 103X, 210, 203	12/5/2009	TP
709	202, 237, 224, 225, 227	12/5/2009	TP
715	507	12/12/2009	TP
710	008	12/5/2009	TP
711	170	12/5/2009	TP
713	170	12/5/2009	TP
705	1	12/4/2009	TP

	/Thuy N Pardo/ Primary Examiner.Art Unit 2627
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